PATENT 450100-05079



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Takashi YOKOKAWA et al.

International Application No.:

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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP04/005562. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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#### **REMARKS**

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP Attorneys for Applicants

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Enclosures

Sheet 1 of 1

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-05079  SERIAL NO. Filed Concurrently Herewith		
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	APPLICANT Takashi YOKOKAWA et al.		
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		· <sub>p</sub>	U.:	S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMB	ER DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6, 539, 367	03/25/03	Blanksby et al.			
	AB						
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EXAMINER INITIAL		DOCUMENT NUMB	ER DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	JP 2003-269302	09/25/03	Japan			
	AM	JP 2002-33670	01/31/02	Japan			
	AN	EP 1 158 682	11/28/01	Europe			
	AO						
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		OTHER	PRIOR ART (In	cluding Author, Title, Date, Pertine	ent Pages, Etc.)		
	AQ			nitectures for a Class of LD PC Code lume 2, November 2002, p. 26-29	es', IEEE Internat	ional Symposiur	n on Circuits and
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